_	 arch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/692,956	YUAN, BIN
Examiner	Art Unit
Isiaka O. Akanbi	2877

SEARCHED			
Class	Subclass	Date	Examiner
356	124,399- 401	1/7/2006	IOA
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
See Attached .CLM search Query		1/7/2006	IOA

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East (US-PGPUB; USPAT; USOCR; EPO)- See Search History Printout	1/7/2006	IOA	